

**Search Notes**

Application/Control No.

10/041,761

Examiner

Hung Q. Dang

Applicant(s)/Patent under  
Reexamination

YOON ET AL.

Art Unit

2633

**SEARCHED**

Class	Subclass	Date	Examiner
386	125	8/1/2006	HQD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventors' name search	7/25/2006	HQD
STIC Plus Search	6/2/2006	HQD
US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB (see Search History attached)	7/25/2006	HQD